Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/528,034	KERSHAW, MATTHEW J.
Examiner	Art Unit
Kiet T. Nguyen	2881

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Class	Subclass	Date	Examiner
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INT	ERFERENC	E SEARCHI	ED
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST including Interference Searched	1/20/2006	KN		
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